## Notice of References Cited Application/Control No. 10/726,543 Examiner Sang Nguyen Applicant(s)/Patent Under Reexamination STUDER ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,124,815	06-1992	Chang, Byung J.	359/10
*	В	US-5,121,371	06-1992	Farnsworth et al.	369/44.26
*	С	US-5,117,296	05-1992	Hoebing, John L.	359/21
*	D	US-5,009,502	04-1991	Shih et al.	356/152.1
*	E	US-4,955,694	09-1990	Kaser, Beda	359/15
*	F	US-4,930,847	06-1990	Cederquist, John N.	359/15
*	G	US-4,878,718	11-1989	Gilbreath-Frandsen et al.	359/12
*	Н	US-4,547,037	10-1985	Case, Steven K.	359/15
*	ı	US-4,455,061	06-1984	Case, Steven K.	359/17
*	J	US-4,432,597	02-1984	Bjorklund et al.	359/16
*	К	US-4,312,559	01-1982	Kojima et al.	359/19
*	L	US-4,245,882	01-1981	Chang, Byung J.	359/19
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	P					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

	TOTAL					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.